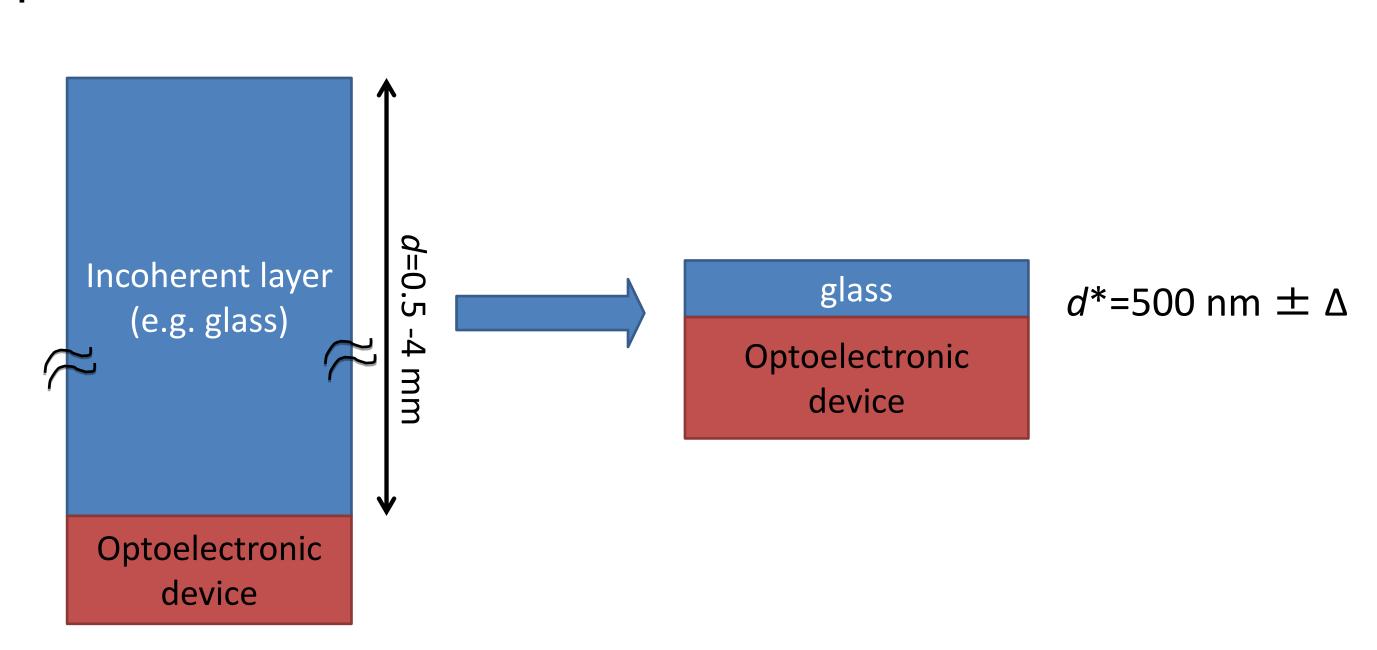
## Incoherent Propagation of Light in Coherent Models

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**Introduction**: In the finite element based modeling and simulation only the coherent propagation of light is considered. However, in reality when light passes a thick layer it loses the phase information and its coherent nature.



Original and modified structure after applying incoherent propagation of light and thining down of layers

**Theory**: Main term of the Poynting vector for forward and backward propagating wave in arbitrary isotropic media

$$\mathbf{E}\mathbf{E}^* = \left(\mathbf{E_0}e^{jk\mathbf{r}} + \mathbf{E_1}e^{jk\mathbf{r} - jk2\mathbf{d} - j\varphi}\right)\left(\mathbf{E_0}e^{jk\mathbf{r}} + \mathbf{E_1}e^{jk\mathbf{r} - jk2\mathbf{d} - j\varphi}\right)^* = \left|\mathbf{E_0}^2\right| + \left|\mathbf{E_0}\mathbf{E_1}^*\right|e^{-jk2\mathbf{d} - j\varphi} + \left|\mathbf{E_0}\mathbf{E_1}^*\right|e^{jk2\mathbf{d} + j\varphi}$$

$$\underbrace{\left|\mathbf{E_0}\mathbf{E_1}^*\right|e^{-jk2\mathbf{d} - j\varphi} + \left|\mathbf{E_0}\mathbf{E_1}^*\right|e^{jk2\mathbf{d} + j\varphi}}_{interference\ term}$$

Interference term has to be eliminated to reproduce the incoherent propagation of light

1) Phase Matching Approach: In this approach the interference term is directly eliminated in one simulation run, first by finding the phase shift  $\varphi$  of the common electric field of reflected waves (in this approach it is assumed  $\varphi$  is known) and then to adjust the thickness to nullify the interference term.

$$d' = Re\left[\frac{\frac{\pi}{2} + m\pi - \varphi}{2k}\right], \quad m = 0, \pm 1, \pm 2, ...$$

where *k* is a wavenumber

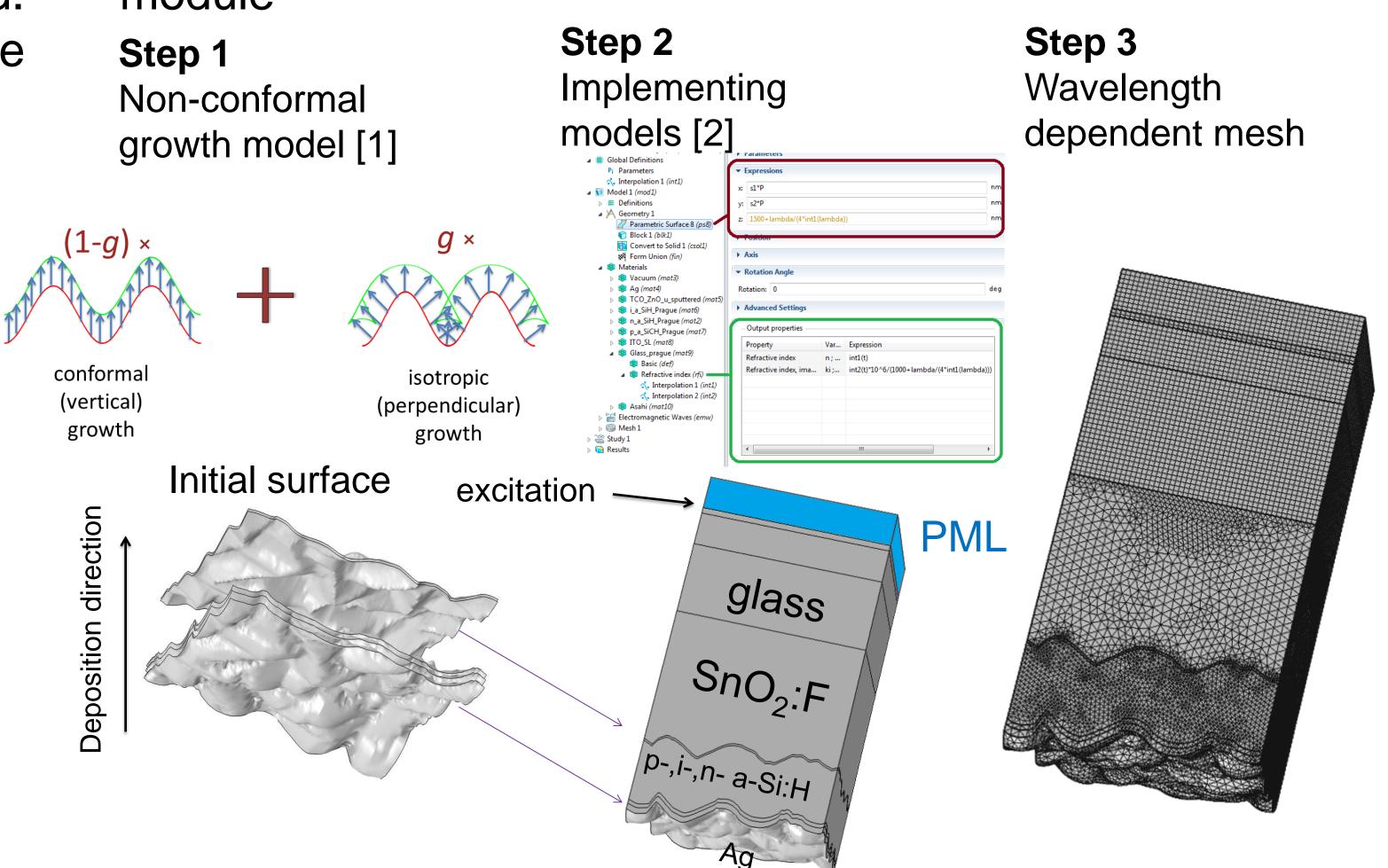
2) Phase Elimination Approach: In this approach we do not need to know the phase of backward propagating wave, thus it is much easier to implement this method to complex structure (e.g. random textures at interfaces of thin-film solar cells). This approach is also suitable for rough interfaces of incoherent layer. Two simulation runs one at original thickness d and another at d'

$$d' = d - Re\left[\frac{\lambda}{4N(\lambda)}\right]$$

3) Thinning down the incoherent layer: Only propagation term is left thus by reducing the thickness of layer the extinction coefficient  $\kappa^*$  needs to be modified

$$k^*(\lambda) = k(\lambda) \frac{d}{d^*}$$

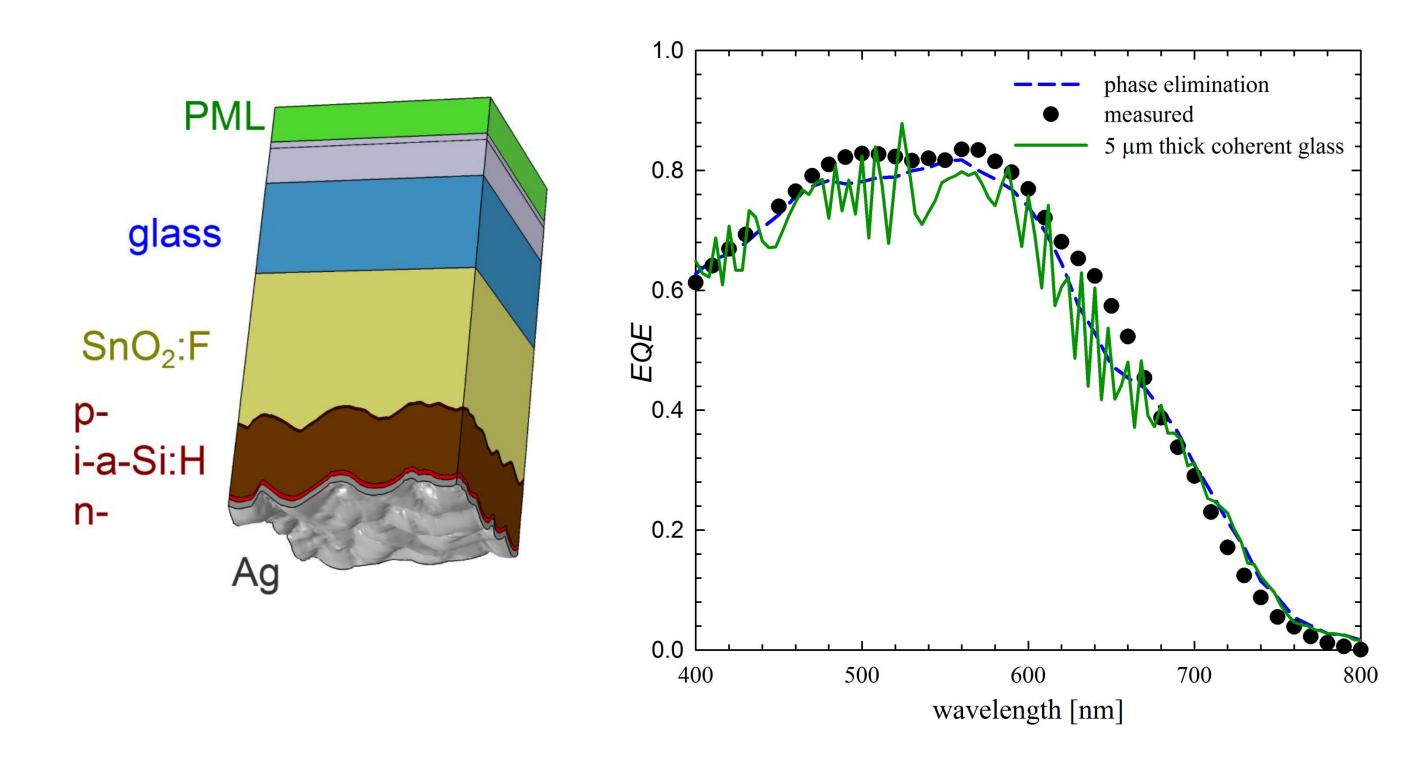
**Numerical model:** COMSOL RF or Wave Optics module



Results: a) thick glass layer

Incoherent glass layer 1 mm thick  $0.8 \qquad T \qquad T$   $0.8 \qquad T \qquad T$   $0.8 \qquad Phase matching, <math>d \sim 1 \mu m$   $0.2 \qquad Phase elimination, <math>d \sim 1 \mu m$   $0.2 \qquad R$   $0.300 \quad 400 \quad 500 \quad 600 \quad 700 \quad 800 \quad 900 \, 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$   $0.500 \quad 600 \quad 700 \quad 800 \quad 900 \, 650 \quad 651 \quad 652$ 

Results: b) thin-film amorphous silicon solar cell



**Conclusions**: All methods showed to be crucial to accurately simulate complete optoelectronic devices.

## References:

- 1. M. Sever et. al., Combined model of non-conformal layer growth for accurate optical simulation of thin-film silicon solar cells, *Sol. energy mater. sol. cells.*, Vol. 119, 59-66 (2013)
- 2. A. Čampa, J. Krč, M. Topič, Two approaches for incoherent propagation of light in rigorous numerical simulations, Progress In Electromagnetics Research, Vol. 137, 187-202 (2013)